



DESCRIPTION

$V_{DS}=20V$

$V_{GS}=\pm 12V$

$ID(A)=6A$

$R_{DS(ON)}=26m\Omega(\text{Max.}) @ V_{GS}=4.5V$

$R_{DS(ON)}=37m\Omega(\text{Max.}) @ V_{GS}=2.5V$

AM3416 is available in a SOT-23 package.

FEATURES

- ESD Protected
- Reliable and Rugged
- Available in a SOT-23 package.

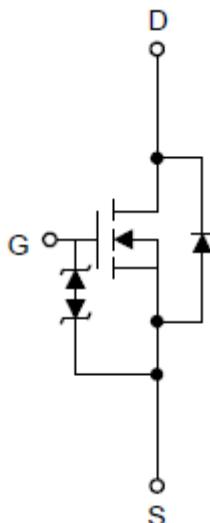
ORDERING INFORMATION

Package Type	Part Number	
SOT-23 SPQ: 3,000pcs/Reel	E3	AM3416E3R
		AM3416E3VR
Note	R: Tape & Reel V: Halogen free Package	
AiT provides all RoHS products		

APPLICATION

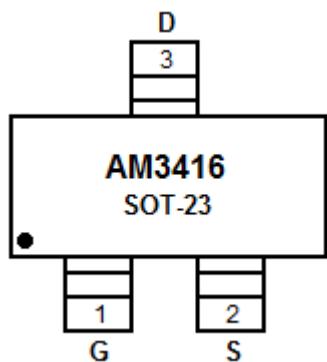
- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

N CHANNEL MOSFET





PIN DESCRIPTION



Top View

Pin #	Symbol	Function
1	G	Gate
2	S	Source
3	D	Drain



ABSOLUTE MAXIMUM RATINGS

T_A = 25°C, unless otherwise noted

V _{DSS} , Drain-Source Voltage	20V	
V _{GSS} , Gate-Source Voltage	±12V	
I _D ^{NOTE1} , Continuous Drain Current(V _{GS} =4.5V)	T _A =25°C	6A
	T _A =100°C	3.7A
I _{DM} ^{NOTE1} , 300µs Pulsed Drain Current(V _{GS} =4.5V)	20A	
I _S ^{NOTE1} , Diode Continuous Forward Current	1.4A	
T _J , Maximum Junction Temperature	150°C	
T _{STG} , Storage Temperature Range	-55°C~150°C	
P _D ^{NOTE1} , Maximum Power Dissipation	T _A =25°C	1.4W
	T _A =100°C	0.5W
R _{θJA} ^{NOTE1} , Thermal Resistance-Junction to Ambient	t ≤ 10s	90°C/W
	Steady state	150°C/W

Stress beyond above listed "Absolute Maximum Ratings" may lead permanent damage to the device. These are stress ratings only and operations of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

NOTE1: Surface Mounted on 1in² pad area, t ≤ 10sec.



ELECTRICAL CHARACTERISTICS

$T_A = 25^\circ\text{C}$, unless otherwise noted

Parameter	Symbol	Conditions	Min	Typ.	Max	Units
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=250\mu\text{A}$	20	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=16\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	μA
		$T_J=85^\circ\text{C}$	-	-	30	
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{DS}}=250\mu\text{A}$	0.5	0.7	1.5	V
Gate Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 10\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 10	μA
Drain-Source On-state Resistance	$R_{\text{DS}(\text{ON})}$ NOTE2	$V_{\text{GS}}=4.5\text{V}, I_{\text{DS}}=6\text{A}$	-	22	26	$\text{m}\Omega$
		$V_{\text{GS}}=2.5\text{V}, I_{\text{DS}}=5\text{A}$	-	29	37	
Diode Characteristics						
Diode Forward Voltage	V_{SD} NOTE2	$I_{\text{SD}}=1.3\text{A}, V_{\text{GS}}=0\text{V}$	-	0.8	1.3	V
Reverse Recovery Time	t_{rr} NOTE3	$I_{\text{DS}}=4\text{A}, dI_{\text{SD}}/dt=100\text{A}/\mu\text{s}$	-	16	-	ns
Reverse Recovery Charge	Q_{rr} NOTE3		-	10	-	nC
Dynamic Characteristics NOTE3						
Gate Resistance	R_G	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, F=1\text{MHz}$	-	4	-	Ω
Input Capacitance	C_{iss}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=10\text{V},$ $\text{Frequency}=1.0\text{MHz}$	-	600	800	pF
Output Capacitance	C_{oss}		-	135	180	
Reverse Transfer Capacitance	C_{rss}		-	125	175	
Turn-on Delay Time	$t_{\text{d}(\text{ON})}$	$V_{\text{DD}}=10\text{V}, R_L=10\Omega,$ $I_{\text{DS}}=1\text{A}, V_{\text{GEN}}=4.5\text{V},$ $R_G=6\Omega$	-	5	10	ns
Turn-on Rise Time	t_r		-	9	17	
Turn-off Delay Time	$t_{\text{d}(\text{OFF})}$		-	25	46	
Turn-off Fall Time	t_f		-	5	10	
Gate Charge Characteristics NOTE3						
Total Gate Charge	Q_g	$V_{\text{DS}}=10\text{V}, V_{\text{GS}}=4.5\text{V},$ $I_{\text{DS}}=4\text{A}$	-	12	17	nC
Gate-Source Charge	Q_{gs}		-	1.4	-	
Gate-Drain Charge	Q_{gd}		-	4.4	-	

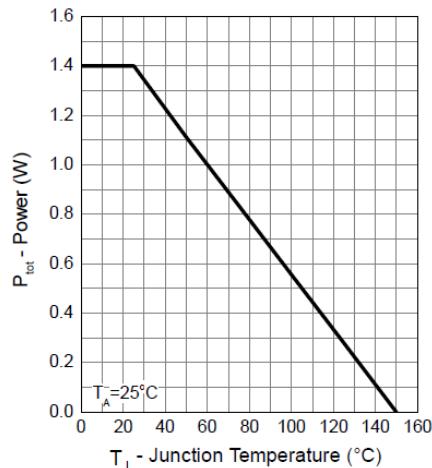
NOTE2: Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.

NOTE3: Guaranteed by design, not subject to production testing.

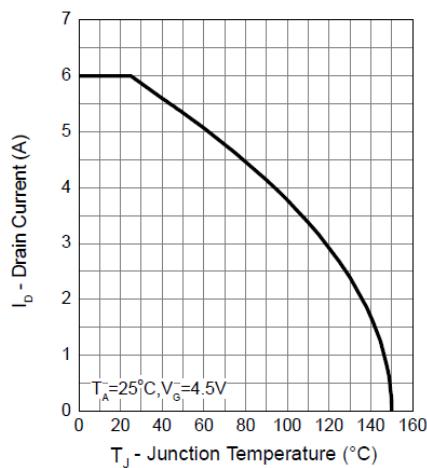


TYPICAL CHARACTERISTICS

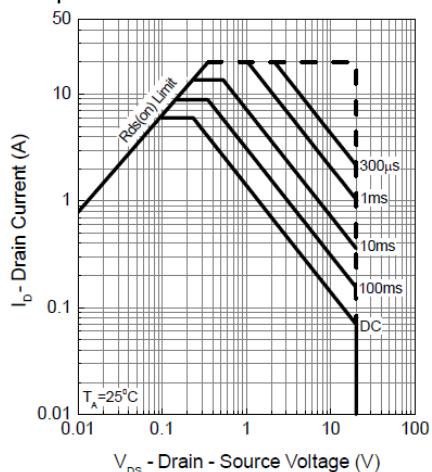
1. Power Dissipation



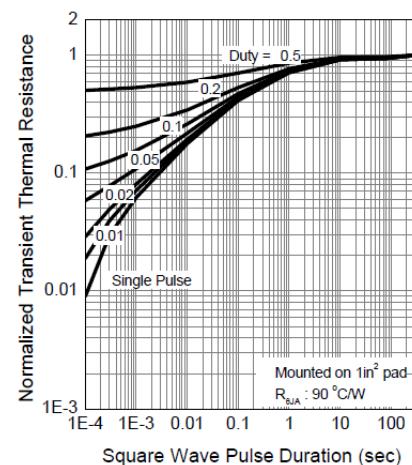
2. Drain Current



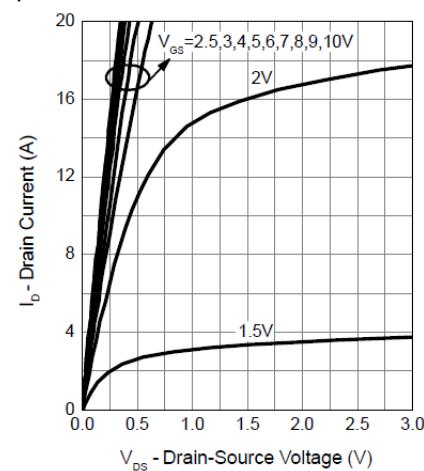
3. Safe Operation Area



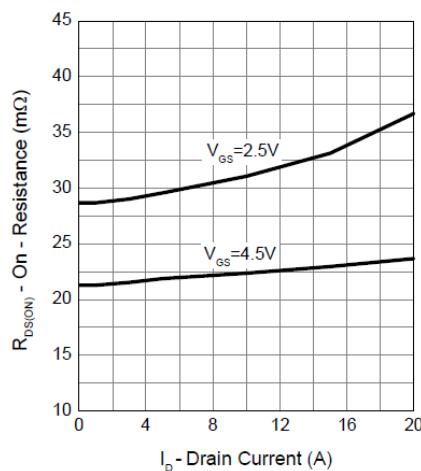
4. Thermal Transient Impedance



5. Output Characteristics

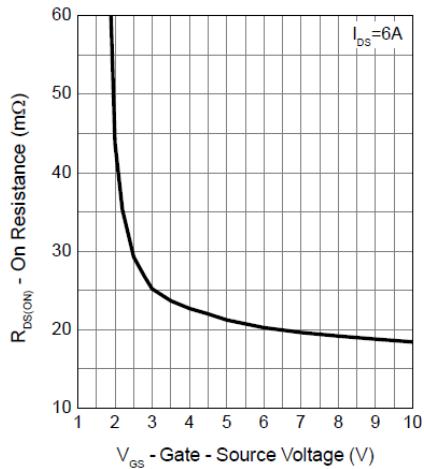


6. Drain-Source On Resistance

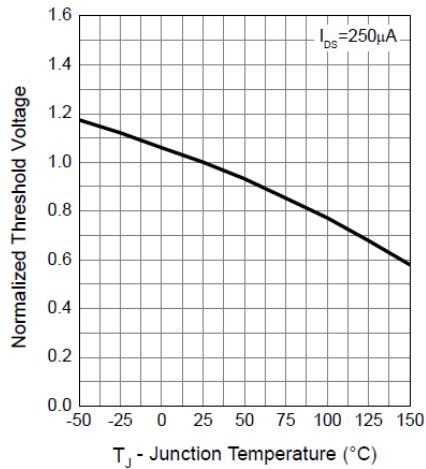




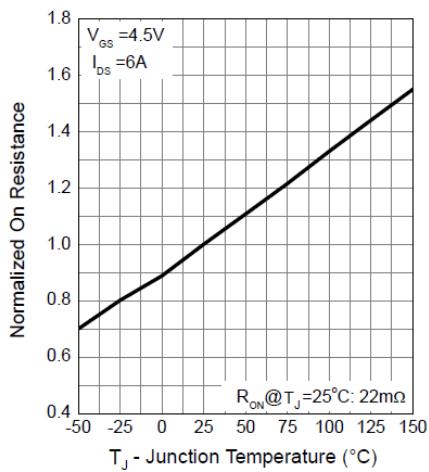
7. Gate-Source On Resistance



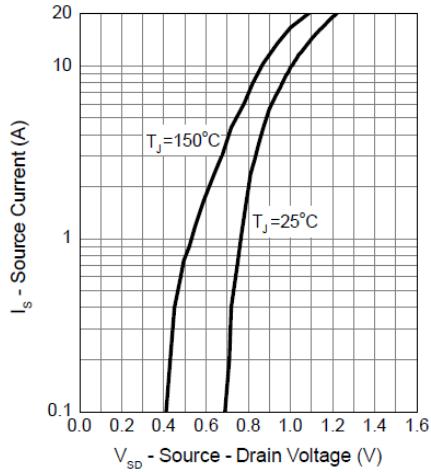
8. Gate Threshold Voltage



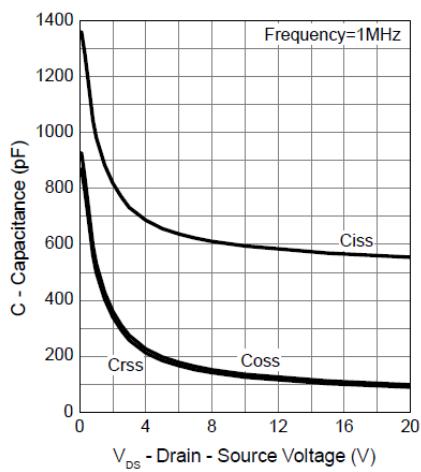
9. Drain-Source On Resistance



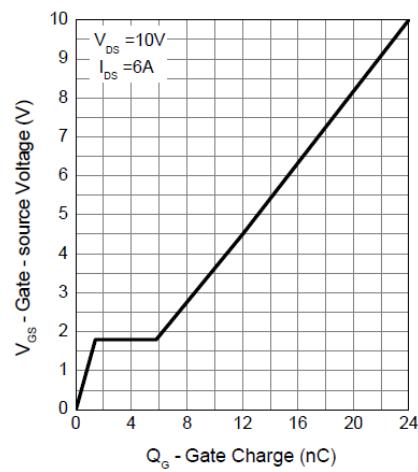
10. Source-Drain Diode Forward



11. Capacitance



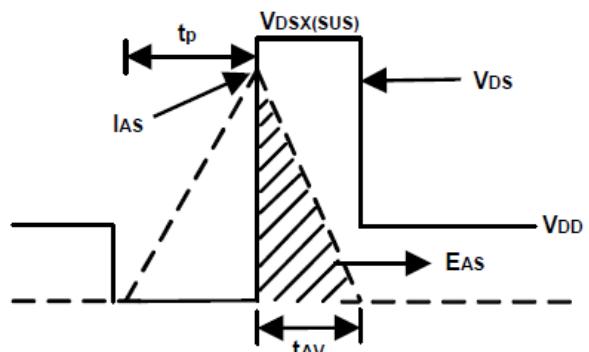
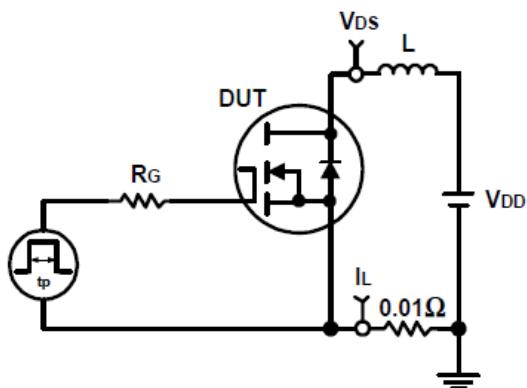
12. Gate Charge



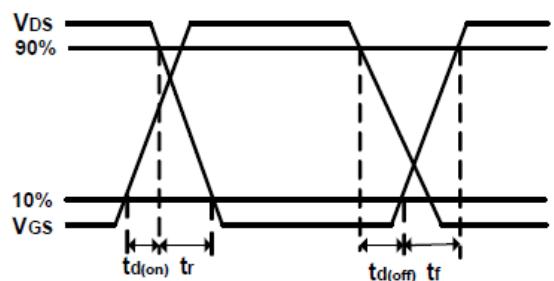
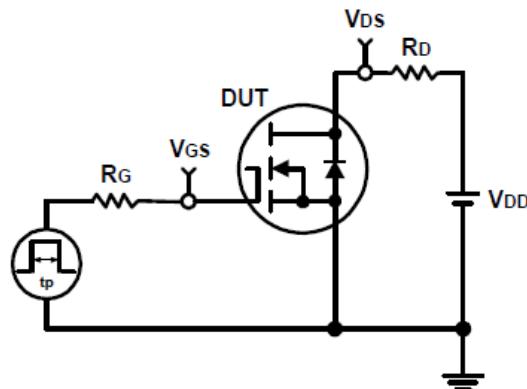


TEST CIRCUIT

1. Avalanche Test Circuit and Waveforms



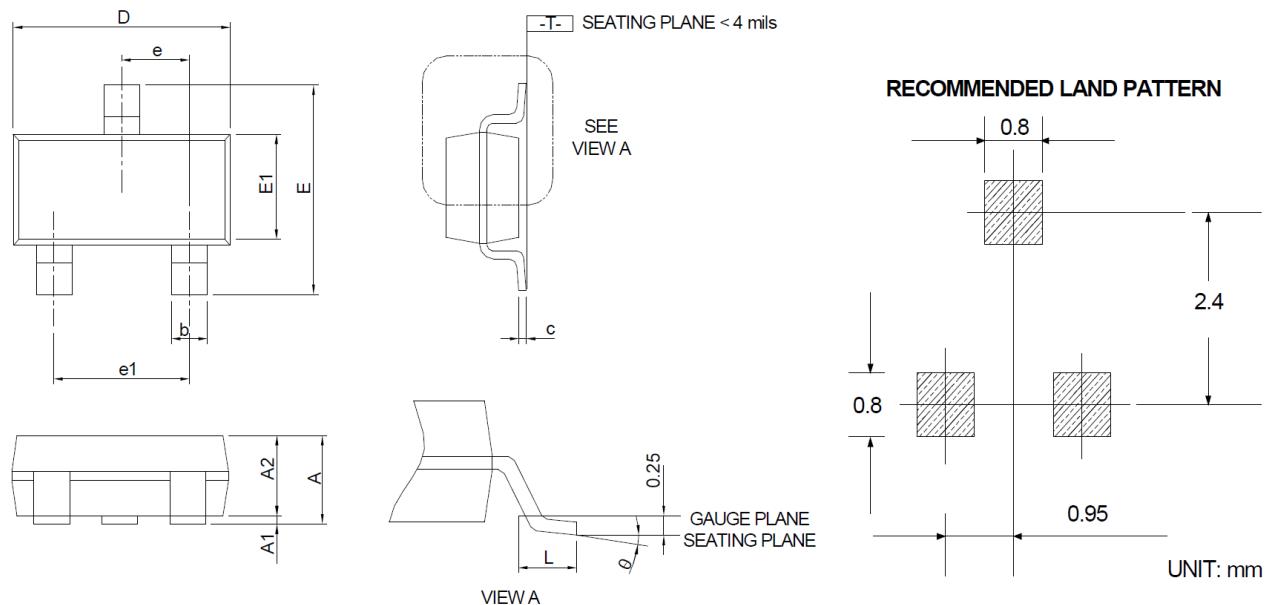
2. Switching Time Test Circuit and Waveforms





PACKAGE INFORMATION

Dimension in SOT-23 Package (Unit: mm)



Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	-	1.20	-	0.047
A1	0.00	0.08	0.000	0.003
A2	0.90	1.12	0.035	0.044
b	0.30	0.50	0.012	0.020
c	0.08	0.22	0.003	0.009
D	2.70	3.10	0.106	0.122
E	2.60	3.00	0.102	0.188
E1	1.40	1.80	0.055	0.071
e	0.950 BSC		0.037 BSC	
e1	1.900 BSC		0.075 BSC	
L	0.30	0.60	0.012	0.024
θ	0°	8°	0°	8°



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